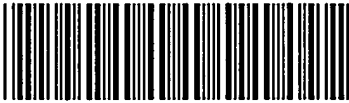


**Search Notes**

Application/Control No.

10/666,462

Examiner

Hae M. Hyeon

Applicant(s)/Patent under  
Reexamination

STONE ET AL.

Art Unit

2839

**SEARCHED**

Class	Subclass	Date	Examiner
Search	Updated	10/05	hnh

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR